## Notice of References Cited Application/Control No. 10/724,119 Examiner Patricia T. Nguyen Applicant(s)/Patent Under Reexamination CHO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-6,104,246 A	08-2000	LaFerrara et al.	330/282
*	В	US-5,355,096 A	10-1994	Kobayashi, Kevin W.	330/278
*	С	US-4,099,134	07-1978	Schroder, Ernst	330/51
*	D	US-6,842,071 B1	01-2005	Retz et al.	330/133
*	Е	US-6,331,804 B1	12-2001	Shimizu et al.	330/285
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.